



Product Change Notification

Date: Wednesday, March 16, 2011

PCN#: 140A00198

Subject: VOL test condition to 10mA on Flash modules

Dear Customer,

In an effort to better communicate to you, our user community, we have implemented a e-mail version for our PCN process in addition to our PCN website. While you may receive a notification from us concerning a particular part or part numbers, it is not an indication that you use or have ordered these particular parts, but merely a communication to notify our user community as a whole. Please review your sales orders, POs, records, etc. to determine if this particular PCN impacts your activities or affects your business.

Microsemi Power and Microelectronics Group wishes to inform you of operational condition changes to all package versions of the following products:

WMF2M8-xxx5, WF2M16-xxx5, WF2M8-xxx, WF2M32-xxx5, WF4M32-xxx5, 5962-97610xxx, 5962-97609xxx

Due to the die performance characteristics over the operating temperature of the product Microsemi is changing the VOL test condition to 10mA from 12mA. This change is effective immediately; please contact the factory for any questions.

As technology moves at a much faster pace, advanced embedded electronic components play a more strategic role. Constant changes and advancements in technology mandate that we anticipate changes and directions in technology for the benefit of our customers. As one of the pioneers in advanced semiconductor packaging and high-density memory solutions, we stand ready to assist you in managing this evolution of technology. If we can provide any additional assistance, please contact us at 602.437.1520 or complete a contact form at www.whiteedc.com/contact_us.html.

Best regards,
Microsemi Power and Microelectronics Engineering Group
